

AD7329 ANALOG INPUTS

The AD7329 analog inputs can be configured as eight single-ended inputs, four true differential input pairs, seven pseudo differential inputs, or four pseudo differential input pairs.

The AD732x family of ADCs is designed using the *i*CMOS process and can accept true bipolar analog input signals. Some bipolar input ADCs use a resistive structure on the analog inputs to scale and level shift the bipolar signal into a voltage range required by the internal ADC. The disadvantage of these resistive analog input ADCs is that the source driving these analog inputs realizes very low source impedance and, thus, a larger input current is required to drive these inputs.

The equivalent analog input structure of the AD7329 is shown in Figure 2. The AD7329 samples the bipolar analog input signal directly on the ADC sampling capacitor and, therefore, less current is required to drive the AD7329 input structure than the resistive input ADCs.

The analog input channels on the AD7329 are routed through an on-chip multiplexer. The outputs of this multiplexer are routed out to the MUX_{OUT+} and MUX_{OUT-} pins. The AD7329 also features the ADC_{IN+} and ADC_{IN-} pins. The ADC_{IN+} and ADC_{IN-} pins provide access to the AD7329 track-and-hold circuit and the sampling capacitor of the ADC.

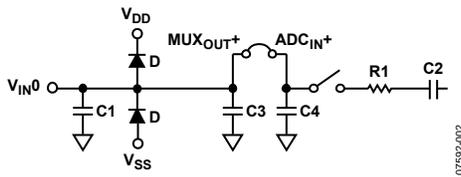


Figure 2. AD7329 Analog Input Structure—Single-Ended Mode

When the MUX_{OUT+} pin connects directly to the ADC_{IN+} pin, the AD7329 operates like many other ADCs. The input signal is sampled directly to the sampling capacitor. The source driving the AD7329 in this configuration needs to provide the current required to drive the ADC input, and settle to the required accuracy within the acquisition time of the ADC (300 ns).

Figure 3 shows the current required to drive the AD7329 analog inputs when the MUX_{OUT+} pin is shorted to the ADC_{IN+} pin. The plot shows that as the sampling rate increases, the current required to drive the analog inputs increases as well.

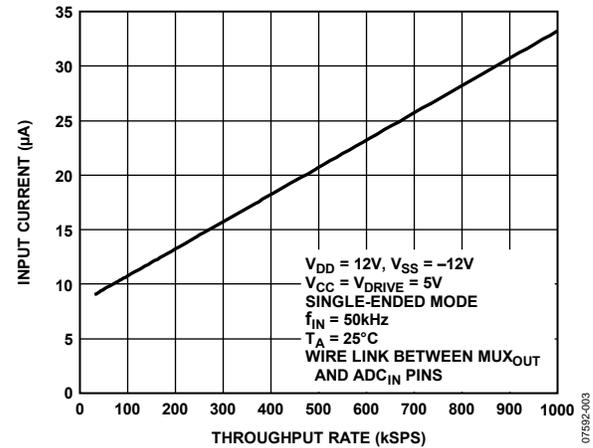


Figure 3. Input Current vs. Throughput Rate with Wire Link Between MUX_{OUT} and ADC_{IN} Pins

As with all SAR converters when the internal track-and-hold switch goes from hold to track, there is a transient kick back from the ADC. The source driving the AD7329 must be able to recover from this transient and settle to the required accuracy within the acquisition time of the ADC. For applications operating at the maximum sampling frequency, it may be necessary to use an input buffer amplifier to drive the ADC and isolate the source from the ADC track-and-hold switch.

The flexible design on the AD7329 allows an op amp to be placed between the MUX_{OUT} and ADC_{IN} pins. In this configuration, the AD7329 boasts very high analog input impedance and the op amp also functions to isolate the source from the AD7329 input structure.

The op amp used in this configuration must be capable of accepting bipolar signals up to ± 10 V. The signals from the MUX_{OUT} pins are still high voltage bipolar signals. In Figure 4, the AD8021 low noise high speed amplifier is used. The AD8021 can accommodate the large bipolar analog input signals while still being able to settle within the required acquisition time of the ADC.

The input impedance that the source driving the AD7329 sees is now the input impedance of the AD8021. In this configuration, the current required by the source to drive the AD7329 is $< 0.2 \mu\text{A}$ with the AD8021 placed between the MUX_{OUT} and ADC_{IN} pins.

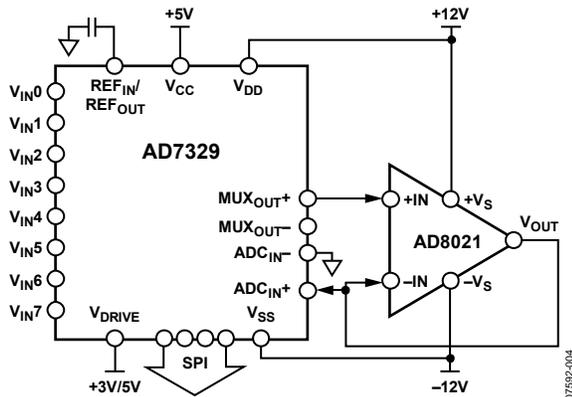


Figure 4. Buffer Between MUX_OUT and ADC_IN Configuration for AD7329

Figure 5 shows the current required to drive the AD7329 using the configuration outlined in Figure 4. This input current vs. throughput rate plot was generated during conversions on a single channel.

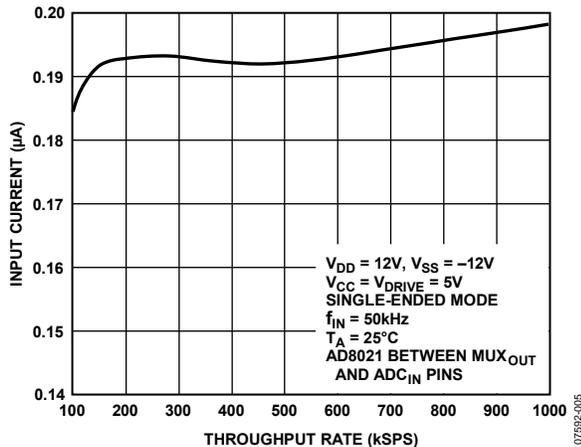


Figure 5. Input Current vs. Throughput Rate with AD8021 Connected Between MUX_OUT and ADC_IN Pins

This configuration has the advantage that at the maximum sampling frequencies a single op amp can be used for eight analog input channels. The analog input impedance of the AD7329, as seen by the source, is in the MΩ region and very little current is required to drive the eight analog input pins. The op amp between the MUX_OUT and ADC_IN pins isolates the source from the switching nature of the ADC input. This configuration reduces component count, board area, and board cost.

Depending on the application requirements, analog input voltages, supply voltage, and sampling frequencies, other bipolar input op amps can be used between the MUX_OUT and ADC_IN pins on the AD7329.

BIPOLAR ANALOG INPUT SIGNALS

The analog input channels on the AD7329 can be independently programmed to accept one of four input signals. The AD7329 can accept input signals of $\pm 4 \times V_{REF}$, $\pm 2 \times V_{REF}$, $\pm V_{REF}$, and 0 to $4 \times V_{REF}$. Using the internal 2.5 V reference, these input ranges translate to be ± 10 V, ± 5 V, ± 2.5 V, and 0 V to +10 V. The AD7329 also allows for an external reference voltage to be applied to the REF_IN/REF_OUT pin. The specified voltage input range on the reference voltage is from 2.5 V to 3 V. With a 3 V external reference, the AD7329 can accept input signals of ± 12 V, ± 6 V, ± 3 V, and 0 V to +12 V. In differential input mode, the AD7329 can accept input signals of ± 24 V, ± 12 V, ± 6 V and 0 V to +24 V differential with a 3 V external reference, depending on which range was selected. When increasing the AD7329 reference input voltage and, thus, the analog input voltages, the buffer op amp between the MUX_OUT and ADC_IN pins needs to be able to accommodate these larger bipolar input signals.

When increasing the analog input voltages on the AD7329 the VDD and VSS supply voltages should be equal to or greater than the maximum analog input voltage applied to the ADC. At the maximum sampling frequency, as the VDD and VSS supplies are reduced, the THD performance of the AD7329 degrades (see Figure 6). Therefore, the VDD and VSS supply voltages used in an application depend on the THD performance the application requires. As the VDD and VSS supplies are reduced, the on resistance (R_{ON}) of the input multiplexer and the track-and-hold switch increase. To meet the specified performance when using the minimum VDD and VSS supplies for the analog input ranges, the overall sampling rate of the AD7329 should be reduced. This allows more settling time for the ADC to compensate for this increase R_{ON} of the input multiplexer.

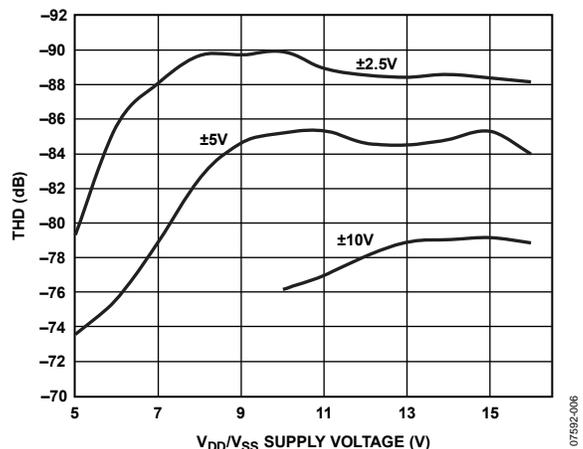


Figure 6. THD vs. Power Supply Voltage

In addition to converting larger bipolar analog input signals, the AD7329 can also be configured to accommodate signals in the millivolt range. By placing gain around the op amp, configured as in Figure 7, the AD7329 can convert small signals in the millivolt range range.

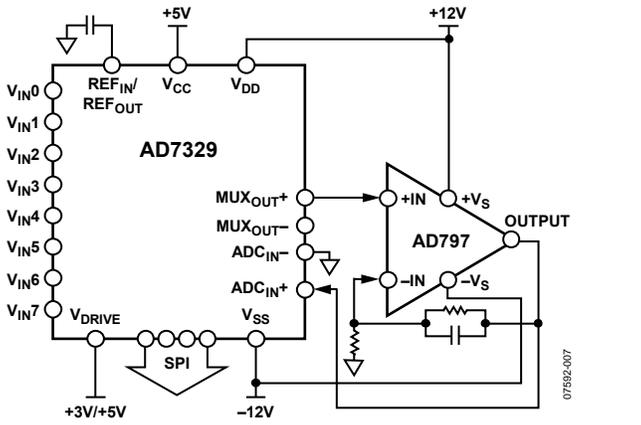


Figure 7. Gain Stage Between MUX_{OUT} and ADC_{IN} Configuration for AD7329

Using the configuration shown in Figure 7, small signals in the mV range can be applied to the analog inputs; these signals are then gained up through the AD797 device. The gained up signal is then applied to the ADC_{IN} pin, which in turn connects to the internal sampling capacitor through the track-and-hold switch.

The gain on the AD797 can be chosen to ensure that the signal applied to the ADC_{IN} pins uses the full dynamic range of the ADC. This, in turn, yields better results from the AD7329.

Table 1 shows that the performance achieved on the ±10 V range at 1 MSPS while varying the gain on the AD797 op amp between the MUX_{OUT} and ADC_{IN} pins using single-ended mode and 10 kHz input tone.

Table 1. AC Performance Results for Different Gain Values Inserted Between the MUX_{OUT} and ADC_{IN} Pins

Gain (V/V)	SNR (dB)	THD (dB)	ENOB (Bits)
1	73.57	-80.80	11.93
20	73.00	-79.91	11.83
50	72.34	-79.90	11.72
100	72.28	-79.81	11.71
200	71.66	-78.99	11.61
500	71.48	-78.46	11.58
1000	69.94	-75.38	11.32

As the gain increases, degradation in SNR and THD becomes noticeable. Using the AD7329, configured as in Figure 7 for gain of 1000, the converter can still achieve greater than 11 effective number of bits (ENOB). Using this value of gain stage between MUX_{OUT} and ADC_{IN} pins, the AD7329 achieves a very wide dynamic range equivalent to a 21-bit ADC.

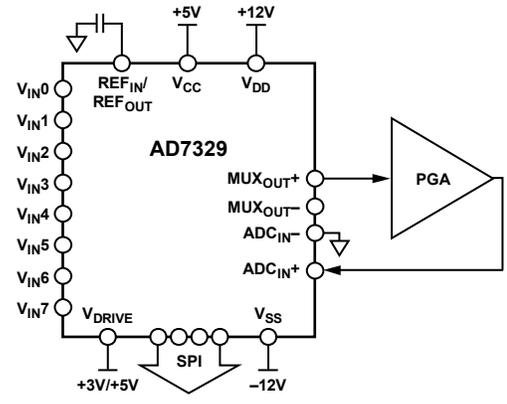


Figure 8. Programmable Gain Amplifier Between MUX_{OUT} and ADC_{IN} Configuration for AD7329

In some applications, it may be necessary to change the gain for varying the amplitude of the signals for different input channels (see Figure 8). In this case, a multiplexer can be used in the AD797 feedback path, allowing different resistor values to be switched in to change the gain settings. The AD797 and the ADG412 are recommended parts, for designing programmable gain amplifiers (PGAs). Figure 9 shows the proposed schematic for PGA applications.

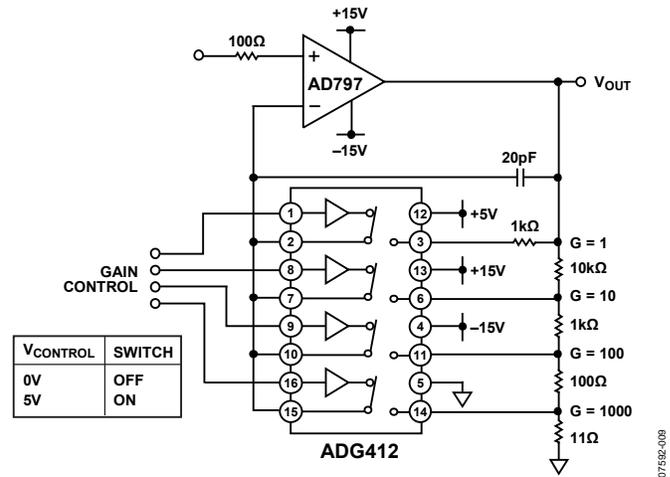


Figure 9. A Very Low Noise PGA Using the AD797 and the ADG412

CONCLUSION

The AD7329 is a versatile device. Significant cost savings can be realized for the bill of materials in a data acquisition system. Only one amplifier is used to provide the high input impedance required for eight analog input channels, thereby saving the cost of seven amplifiers. Data acquisition systems utilizing the AD7329 can interface to sensors/transducers with dynamic ranges that can vary from the millivolt range up to ±12 V. This ability is due to the addition of a programmable gain amplifier.